Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/517,016	OHASHI ET AL.	
Examiner	Art Unit	
Mark T. Le	3617	

SEARCHED						
Class	Subclass	Date	Examiner			
2.12	12	1.00				
213	1.3	12/06				
	75GT					
	76					
105	3					
	4.1					
·	4.2 4.3 4.4					
	4.4					
	159	$\perp$				
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
See EAST Search History	12/06			